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# Independent Clock Dual HOTLink II™ Serializer

#### **Features**

- Second-generation HOTLink® technology
- Compliant to SMPTE 292M and SMPTE 259M video standards
- Dual-channel video serializer
  - □ 195- to 1500-Mbps serial data signaling rate
  - □ Simultaneous operation at different signaling rates
- Supports half-rate and full-rate clocking
- Internal phase-locked loops (PLLs) with no external PLL components
- Redundant differential PECL-compatible serial outputs per channel
  - □ No external bias resistors required
  - □ Signaling-rate controlled edge-rates
  - □ Internal source termination
- Synchronous LVTTL parallel interface
- JTAG boundary scan
- Built-In Self-Test (BIST) for at-speed link testing
- Low-power 1.4 W @ 3.3 V typical
- Single 3.3 V supply
- Thermally enhanced BGA
- Pb-free package option available
- 0.25µ BiCMOS technology

## **Functional Description**

The CYV15G0203TB Independent Clock Dual HOTLink II™ point-to-multipoint Serializer is a point-to-point or communications building block enabling transfer of data over a variety of high-speed serial links including SMPTE 292M and SMPTE 259M video applications. It supports signaling rates in the range of 195 to 1500 Mbps per serial link. The two channels are independent and can simultaneously operate at different rates. Each channel accepts 10-bit parallel characters in an Input Register and converts them to serial data. Figure 1 illustrates typical connections between independent video co-processors CYV15G0203TB and corresponding Serializer CYV15G0204RB Reclocking Deserializer chips.

The CYV15G0203TB satisfies the SMPTE-259M and SMPTE-292M compliance as per SMPTE EG34-1999 Pathological Test Requirements.

As a second-generation HOTLink device, the CYV15G0203TB extends the HOTLink family with enhanced levels of integration and faster data rates, while maintaining serial-link compatibility (data, and BIST) with other HOTLink devices. Each channel of the CYV15G0203TB Dual HOTLink II device accepts scrambled 10-bit transmission characters. These characters are serialized and output from dual Positive ECL (PECL) compatible differential transmission-line drivers at a bit-rate of either 10- or 20-times the input reference clock for that channel.

Each channel contains an independent BIST pattern generator. This BIST hardware allows at-speed testing of the high-speed serial data paths in each transmit section of this device, each receive section of a connected HOTLink II device, and across the interconnecting links.

The CYV15G0203TB is ideal for SMPTE applications where different data rates and serial interface standards are necessary for each channel. Some applications include multi-format routers, switchers, format converters, and cameras.

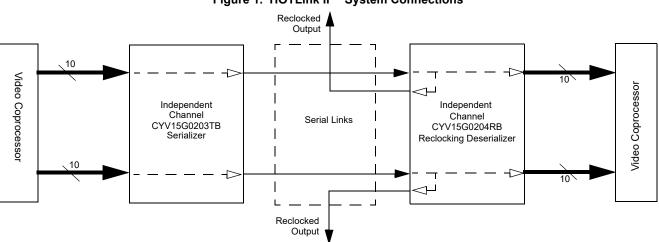
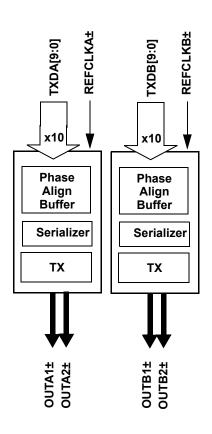


Figure 1. HOTLink II™ System Connections

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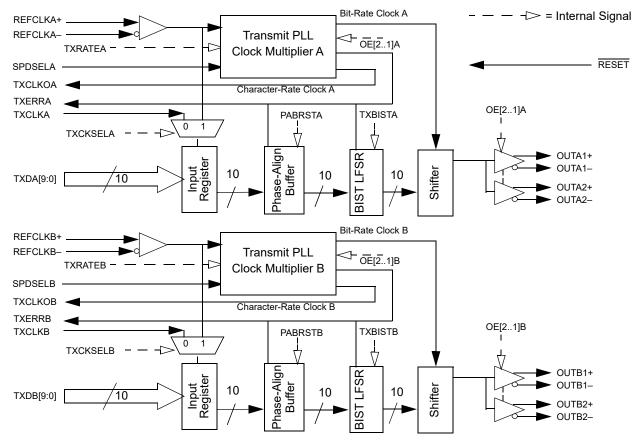


## CYV15G0203TB Serializer Logic Block Diagram

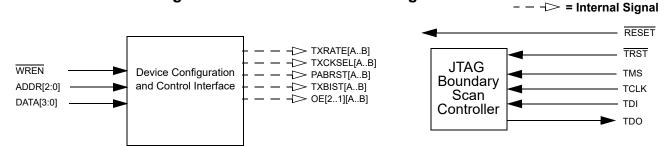




## Serializer Path Block Diagram



## JTAG and Device Configuration and Control Block Diagram





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# Pin Configuration

Top View [1]

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20
Α	NC	NC	NC	NC	V <sub>CC</sub>	NC	OUT B1–	GND	GND	OUT B2-	GND	OUT A1–	GND	GND	OUT A2-	V <sub>CC</sub>	V <sub>CC</sub>	NC	V <sub>CC</sub>	NC
В	V <sub>CC</sub>	NC	V <sub>CC</sub>	NC	V <sub>CC</sub>	V <sub>CC</sub>	OUT B1+	GND	NC	OUT B2+	NC	OUT A1+	GND	NC	OUT A2+	V <sub>CC</sub>	NC	NC	NC	NC
С	TDI	TMS	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	NC	NC	GND	NC	NC	DATA [2]	DATA [0]	GND	NC	SPD SELB	V <sub>CC</sub>	NC	TRST	GND	TDO
D	TCLK	RESET	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	NC	GND	GND	DATA [3]	DATA [1]	GND	GND	GND	NC	V <sub>CC</sub>	NC	NC	SCAN EN2	TMEN3
E	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>					ı								V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
F	NC	NC	V <sub>CC</sub>	NC													NC	NC	NC	NC
G	GND	WREN	GND	GND													NC	NC	SPD SELA	NC
Н	GND	GND	GND	GND													GND	GND	GND	GND
J	GND	GND	GND	GND													NC	NC	NC	NC
K	NC	NC	GND	GND													NC	NC	NC	NC
L	NC	NC	NC	GND													NC	NC	NC	GND
М	NC	NC	NC	NC													NC	NC	NC	GND
N	GND	GND	GND	GND													GND	GND	GND	GND
Р	NC	NC	NC	NC													GND	GND	GND	GND
R	NC	NC	NC	NC													V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
Т	V <sub>cc</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>cc</sub>													V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
U	TX DB[0]	TX DB[1]	TX DB[2]	TX DB[9]	V <sub>CC</sub>	NC	NC	GND	TX DA[9]	ADDR [0]	REF CLKB-	TX DA[1]	GND	TX DA[4]	TX DA[8]	V <sub>CC</sub>	NC	V <sub>CC</sub>	NC	NC
V	TX DB[3]	TX DB[4]	TX DB[8]	NC	V <sub>CC</sub>	NC	NC	GND	NC	GND	REF	TX CLKOA	GND	TX DA[3]	TX DA[7]	V <sub>CC</sub>	NC	NC	NC	NC
W	TX DB[5]	TX DB[7]	NC	NC	V <sub>CC</sub>	NC	NC	GND	ADDR [2]	ADDR [1]	NC	TX ERRA	GND	TX DA[2]	TX DA[6]	V <sub>CC</sub>	NC	REF CLKA+	NC	NC
Y	TX DB[6]	TX CLKB	NC	NC	V <sub>CC</sub>	NC	NC		TX CLKOB	NC	TX CLKA	NC	GND	TX DA[0]	TX DA[5]	V <sub>CC</sub>	TX	REF CLKA-	NC	NC

Note
1. NC = Do not connect.



# Pin Configuration

Bottom View [2]

	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1
Α	NC	V <sub>CC</sub>	NC	V <sub>CC</sub>	V <sub>CC</sub>	OUT A2-	GND	GND	OUT A1–	GND	OUT B2-	GND	GND	OUT B1-	NC	V <sub>CC</sub>	NC	NC	NC	NC
В	NC	NC	NC	NC	V <sub>CC</sub>	OUT A2+	NC	GND	OUT A1+	NC	OUT B2+	NC	GND	OUT B1+	V <sub>CC</sub>	V <sub>CC</sub>	NC	V <sub>CC</sub>	NC	V <sub>CC</sub>
С	TDO	GND	TRST	NC	V <sub>CC</sub>	SPD SELB	NC	GND	DATA [0]	DATA [2]	NC	NC	GND	NC	NC	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	TMS	TDI
D	TMEN3	SCAN EN2	NC	NC	V <sub>CC</sub>	NC	GND	GND	GND	DATA [1]	DATA [3]	GND	GND	NC	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	RESET	TCLK
Е	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	- 00		<b>.</b>			1.7	[4]				- 00	- 00	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
F	NC NC	NC	NC NC	NC													NC			NC NC
G		SPD																V <sub>CC</sub>	NC	
Н	NC	SELA	NC	NC													GND	GND	WREN	GND
J	GND	GND	GND	GND													GND	GND	GND	GND
	NC	NC	NC	NC													GND	GND	GND	GND
K	NC	NC	NC	NC													GND	GND	NC	NC
L	GND	NC	NC	NC													GND	NC	NC	NC
М	GND	NC	NC	NC													NC	NC	NC	NC
N	GND	GND	GND	GND													GND	GND	GND	GND
Р	GND	GND	GND	GND													NC	NC	NC	NC
R																	NC	NC	NC	NC
Т	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>																
U	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>		TX	TX		TX	REF	ADDR	TX					V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
V	NC	NC	V <sub>CC</sub>	NC	V <sub>CC</sub>	DA[8]	DA[4]	GND	DA[1]	CLKB- REF	[0]	DA[9]	GND	NC	NC	V <sub>CC</sub>	DB[9]	DB[2]	DB[1]	DB[0]
	NC	NC	NC	NC	V <sub>CC</sub>	DA[7]	DA[3]	GND	CLKOA	CLKB+		NC	GND	NC	NC	V <sub>CC</sub>	NC	DB[8]	DB[4]	DB[3]
W	NC	NC	REF CLKA+	NC	V <sub>CC</sub>	TX DA[6]	TX DA[2]	GND	TX ERRA	NC	ADDR [1]	ADDR [2]	GND	NC	NC	V <sub>CC</sub>	NC	NC	TX DB[7]	TX DB[5]
Y	NC	NC	REF CLKA-	TX ERRB	V <sub>CC</sub>	TX DA[5]	TX DA[0]	GND	NC	TX CLKA	NC	TX CLKOB	GND	NC	NC	V <sub>CC</sub>	NC	NC	TX CLKB	TX DB[6]

Note
2. NC = Do not connect.



## **Pin Definitions**

### CYV15G0203TB Dual HOTLink II Serializer

Name	I/O Characteristics	Signal Description
Transmit Path	Data and Status Signa	als
TXDA[9:0] TXDB[9:0]	LVTTL Input, synchronous, sampled by the associated TXCLKx <sup>↑</sup> or REFCLKx <sup>↑[3]</sup>	<b>Transmit Data Inputs.</b> TXDx[9:0] data inputs are captured on the rising edge of the transmit interface clock. The transmit interface clock is selected by the TXCKSELx latch via the device configuration interface.
TXERRA TXERRB	LVTTL Output, synchronous to REFCLKx↑ [4], asynchronous to transmit channel enable / disable, asynchronous to loss or return of REFCLKx±	<b>Transmit Path Error</b> . TXERRx is asserted HIGH to indicate detection of a transmit Phase-Align Buffer underflow or overflow. If an underflow or overflow condition is detected, TXERRx, for the channel in error, is asserted HIGH and remains asserted until the transmit Phase-Align Buffer is re-centered with the PABRSTx latch via the device configuration interface. When TXBISTx = 0, the BIST progress is presented on the associated TXERRx output. The TXERRx signal pulses HIGH for one transmit-character clock period to indicate a pass through the BIST sequence once every 511 character times.  TXERRx is also asserted HIGH, when any of the following conditions is true:
		■ The TXPLL for the associated channel is powered down. This occurs when OE2x and OE1x for a given channel are both disabled by setting OE2x = 0 and OE1x = 0.
		■ The absence of the REFCLKx± signal.
Transmit Path	Clock Signals	
REFCLKA± REFCLKB±	Differential LVPECL or single-ended LVTTL input clock	<b>Reference Clock</b> . REFCLKx± clock inputs are used as the timing references for the associated transmit PLL. These input clocks may also be selected to clock the transmit parallel interface. When driven by a single-ended LVCMOS or LVTTL clock source, connect the clock source to either the true or complement REFCLKx input, and leave the alternate REFCLKx input open (floating). When driven by an LVPECL clock source, the clock must be a differential clock, using both inputs.
TXCLKA TXCLKB	LVTTL Clock Input, internal pull-down	<b>Transmit Path Input Clock</b> . When configuration latch TXCKSELx = 0, the associated TXCLKx input is selected as the character-rate input clock for the TXDB[9:0] input. In this mode, the TXCLKx input must be frequency-coherent to its associated TXCLKOx output clock, but may be offset in phase by any amount. Once initialized, TXCLKx is allowed to drift in phase as much as ±180 degrees. If the input phase of TXCLKx drifts beyond the handling capacity of the Phase Align Buffer, TXERRx is asserted to indicate the loss of data, and remains asserted until the Phase Align Buffer is initialized. The phase of the TXCLKx input clock relative to its associated REFCLKx± is initialized when the configuration latch PABRSTx is written as 0. When the associated TXERRx is deasserted, the Phase Align Buffer is initialized and input characters are correctly captured.
TXCLKOA TXCLKOB	LVTTL Output	<b>Transmit Clock Output</b> . TXCLKOx output clock is synthesized by each channel's transmit PLL and operates synchronous to the internal transmit character clock. TXCLKOx operates at either the same frequency as REFCLKx± (TXRATEx = 0), or at twice the frequency of REFCLKx± (TXRATEx = 1). The transmit clock outputs have no fixed phase relationship to REFCLKx±.
Device Control	Signals	
RESET	LVTTL Input, asynchronous, internal pull-up	Asynchronous Device Reset. RESET initial <u>izes all</u> state machines, counters, and configuration latches in the device to a known state. RESET must be asserted LOW for a minimum pulse width. When the reset is removed, all state machines, counters and configuration latches are at an initial state. As per the JTAG specifications the device RESET cannot reset the JTAG controller. Therefore, the JTAG controller has to be reset separately. Refer to JTAG Support on page 11 for the methods to reset the JTAG state machine. See Table 2 on page 11 for the initialize values of the device configuration latches.

- Notes

  3. When REFCLKx± is configured for half-rate operation, these inputs are sampled relative to both the rising and falling edges of the associated REFCLKx±.

  4. When REFCLKx± is configured for half-rate operation, these outputs are presented relative to both the rising and falling edges of the associated REFCLKx±.



## Pin Definitions (continued)

## CYV15G0203TB Dual HOTLink II Serializer (continued)

Name	I/O Characteristics	Signal Description				
SPDSELA SPDSELB	3-Level Select <sup>[5]</sup> static control input	Serial Rate Select. The SPDSELx inputs specify the operating signaling-rate range of each channel's PLL.  LOW = 195–400 MBd  MID = 400–800 MBd  HIGH = 800–1500 MBd.				
Device Configu	ration and Control B	us Signals				
WREN	LVTTL input, asynchronous, internal pull-up	Control Write Enable. The WREN input writes the values of the DATA[3:0] bus into the latch specified by the address location on the ADDR[2:0] bus. <sup>[6]</sup>				
ADDR[2:0]	LVTTL input, asynchronous, internal pull-up	Control Addressing Bus. The ADDR[2:0] bus is the input address bus used to configure the device. The WREN input writes the values of the DATA[3:0] bus into the latch specified by the address location on the ADDR[2:0] bus. <sup>[6]</sup> Table 2 on page 11 lists the configuration latches within the device, and the initialization value of the latches upon the assertion of RESET. Table 3 on page 12 shows how the latches are mapped in the device.				
DATA[3:0]	LVTTL input, asynchronous, internal pull-up	Control Data Bus. The DATA[3:0] bus is the input data bus used to configure the device. The WREN input writes the values of the DATA[3:0] bus into the latch specified by address location on the ADDR[2:0] bus. [6] Table 2 on page 11 lists the configuration latches within the device, and the initialization value of the latches upon the assertion of RESET. Table 3 on page 12 shows how the latches are mapped in the device.				
Internal Device	Configuration Latch	es				
TXCKSEL[AB]	Internal Latch [7]	Transmit Clock Select.				
TXRATE[AB]	Internal Latch [7]	Transmit PLL Clock Rate Select.				
TXBIST[AB]	Internal Latch <sup>[7]</sup>	Transmit Bist Disabled.				
OE2[AB]	Internal Latch <sup>[7]</sup>	Differential Serial Output Driver 2 Enable.				
OE1[AB]	Internal Latch [7]	Differential Serial Output Driver 1 Enable.				
PABRST[AB]	Internal Latch [7]	Transmit Clock Phase Alignment Buffer Reset.				
Factory Test Mo	odes					
SCANEN2	LVTTL input, internal pull-down	<b>Factory Test 2</b> . SCANEN2 input is for factory testing only. This input may be left as a NO CONNECT, or GND only.				
TMEN3	LVTTL input, internal pull-down	<b>Factory Test 3</b> . TMEN3 input is for factory testing only. This input may be left as a NO CONNECT, or GND only.				
Analog I/O						
OUTA1± OUTB1±	CML Differential Output	<b>Primary Differential Serial Data Output</b> . The OUTx1± PECL-compatible CML outputs (+3.3 V referenced) are capable of driving terminated transmission lines or standard fiber-optic transmitter modules, and must be AC-coupled for PECL-compatible connections.				
OUTA2± OUTB2±	CML Differential Output	<b>Secondary Differential Serial Data Output</b> . The OUTx2± PECL-compatible CML outputs (+3.3 V referenced) are capable of driving terminated transmission lines or standard fiber-optic transmitter modules, and must be AC-coupled for PECL-compatible connections.				

#### Notes

S. 3-Level Select inputs are used for static configuration. These are ternary inputs that make use of logic levels of LOW, MID, and HIGH. The LOW level is usually implemented by direct connection to V<sub>SS</sub> (ground). The HIGH level is usually implemented by direct connection to V<sub>CC</sub> (power). The MID level is usually implemented by not connecting the input (left floating), which allows it to self bias to the proper level.
 See Device Configuration and Control Interface on page 10 for detailed information on the operation of the Configuration Interface.
 See Device Configuration and Control Interface on page 10 for detailed information on the internal latches.



#### Pin Definitions (continued)

#### CYV15G0203TB Dual HOTLink II Serializer (continued)

Name	I/O Characteristics	Signal Description
JTAG Interfac	e	
TMS		<b>Test Mode Select</b> . Used to control access to the JTAG Test Modes. If maintained high for ≥ 5 TCLK cycles, the JTAG test controller is reset.
TCLK	LVTTL Input, internal pull-down	JTAG Test Clock.
TDO	3-State LVTTL Output	Test Data Out. JTAG data output buffer. High Z while JTAG test mode is not selected.
TDI	LVTTL Input, internal pull-up	Test Data In. JTAG data input port.
TRST		<b>JTAG reset signal</b> . When asserted (LOW), this input asynchronously resets the JTAG test access port controller.
Power		
V <sub>CC</sub>		+3.3 V Power.
GND		Signal and Power Ground for all internal circuits.

## CYV15G0203TB HOTLink II Operation

The CYV15G0203TB is a highly configurable, independent clocking, dual-channel serializer, designed to support reliable transfer of large quantities of digital video data, using high-speed serial links from multiple sources to multiple destinations. This device supports two 10-bit channels.

## CYV15G0203TB Transmit Data Path

#### Input Register

The parallel input bus TXDx[9:0] can be clocked in using TXCLKx (TXCKSELx = 0) or REFCLKx (TXCKSELx = 1).

#### Phase-Align Buffer

Data from each Input Register is passed to the associated Phase-Align Buffer, when the TXDx[9:0] input registers are clocked using TXCLKx (TXCKSELx = 0 and TXRATEx = 0). When the TXDx[9:0] input registers are clocked using REFCLKx± (TXCKSELx = 1) and REFCLKx± is a full-rate clock, the associated Phase Alignment Buffer in the transmit path is bypassed. These buffers are used to absorb clock phase differences between the TXCLKx input clock and the internal character clock for that channel.

Once initialized, TXCLKx is allowed to drift in phase as much as ±180 degrees. If the input phase of TXCLKx drifts beyond the handling capacity of the Phase Align Buffer, TXERRx is asserted to indicate the loss of data, and remains asserted until the Phase Align Buffer is initialized. The phase of the TXCLKx relative to its associated internal character rate clock is initialized when the configuration latch PABRSTx is written as 0. When the associated TXERRx is deasserted, the Phase Align Buffer is initialized and input characters are correctly captured.

If the phase offset, between the initialized location of the input clock and REFCLKx, exceeds the skew handling capabilities of the Phase-Align Buffer, an error is reported on that channel's TXERRx output. This output indicates an error continuously until the Phase-Align Buffer for that channel is reset. While the error remains active, the transmitter for that channel outputs a continuous "1001111000" character (LSB first) to indicate to the remote receiver that an error condition is present in the link.

#### **Transmit BIST**

Each channel contains an internal pattern generator that can be used to validate both the link and device operation. These generators are enabled by the associated TXBISTx latch via the device configuration interface. When enabled, a register in the associated channel becomes a signature pattern generator by logically converting to a Linear Feedback Shift Register (LFSR). This LFSR generates a 511-character sequence. This provides a predictable yet pseudo-random sequence that can be matched to an identical LFSR in the attached Receiver(s).

A device reset (RESET sampled LOW) presets the BIST Enable Latches to disable BIST on both channels.

All data present at the associated TXDx[9:0] inputs are ignored when BIST is active on that channel.

#### Transmit PLL Clock Multiplier

Each Transmit PLL Clock Multiplier accepts a character-rate or half-character-rate external clock at the associated REFCLKx± input, and that clock is multiplied by 10 or 20 (as selected by TXRATEx) to generate a bit-rate clock for use by the transmit shifter. It also provides a character-rate clock used by the transmit paths, and outputs this character rate clock as TXCLKOx.

Each clock multiplier PLL can accept a REFCLKx± input between 19.5 MHz and 150 MHz, however, this clock range is limited by the operating mode of the CYV15G0203TB clock multiplier (TXRATEx) and by the level on the associated SPDSELx input.

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SPDSELx are 3-level select <sup>[8]</sup> inputs that select one of three operating ranges for the serial data outputs and inputs of the associated channel. The serial signaling-rate and allowable range of REFCLKx± frequencies are listed in Table 1.

**Table 1. Operating Speed Settings** 

SPDSELx	TXRATEx	REFCLKx± Frequency (MHz)	Signaling Rate (Mbps)
LOW	1	reserved	195–400
	0	19.5–40	
MID (Open)	1	20–40	400–800
	0	40–80	
HIGH	1	40–75	800–1500
	0	80–150	

The REFCLKx± inputs are differential inputs with each input internally biased to 1.4 V. If the REFCLKx+ input is connected to a TTL, LVTTL, or LVCMOS clock source, the input signal is recognized when it passes through the internally biased reference point. When driven by a single-ended TTL, LVTTL, or LVCMOS clock source, connect the clock source to either the true or complement REFCLKx input, and leave the alternate REFCLKx input open (floating).

When both the REFCLKx+ and REFCLKx- inputs are connected, the clock source must be a differential clock. This can either be a differential LVPECL clock that is DC-or AC-coupled or a differential LVTTL or LVCMOS clock.

By connecting the REFCLKx- input to an external voltage source, it is possible to adjust the reference point of the REFCLKx+ input for alternate logic levels. When doing so, it is necessary to ensure that the input differential crossing point remains within the parametric range supported by the input.

#### Serial Output Drivers

The serial output interface drivers use differential Current Mode Logic (CML) drivers to provide source-matched drivers for 50  $\Omega$  transmission lines. These drivers accept data from the Transmit Shifter, which shifts the data out LSB first. These drivers have signal swings equivalent to that of standard PECL drivers, and are capable of driving AC-coupled optical modules or transmission lines.

Transmit Channels Enabled

Each driver can be enabled or disabled separately via the device configuration interface.

When a driver is disabled via the configuration interface, it is internally powered down to reduce device power. If both serial drivers for a channel are in this disabled state, the associated internal logic for that channel is also powered down. A device reset (RESET sampled LOW) disables all output drivers.

**Note**. When a disabled channel (i.e., both outputs disabled) is re-enabled:

- $\blacksquare$  data on the serial outputs may not meet all timing specifications for up to 250  $\mu s$
- the state of the phase-align buffer cannot be guaranteed, and a phase-align reset is required if the phase-align buffer is used

## **Device Configuration and Control Interface**

The CYV15G0203TB is highly configurable via the configuration interface. The configuration interface allows each channel to be configured independently. Table 2 on page 11 lists the configuration latches within the device including the initialization value of the latches upon the assertion of RESET. Table 3 on page 12 shows how the latches are mapped in the device. Each row in Table 3 on page 12 maps to a 4-bit latch bank. There are 6 such write-only latch banks. When WREN = 0, the logic value in the DATA[3:0] is latched to the latch bank specified by the values in ADDR[2:0]. The second column of Table 3 on page 12 specifies the channels associated with the corresponding latch bank. For example, the first three latch banks (0, 1 and 2) consist of configuration bits for channel A.

#### **Latch Types**

There are two types of latch banks: static (S) and dynamic (D). Each channel is configured by 2 static and 1 dynamic latch banks. The S type contain those settings that normally do not change for a given application, whereas the D type controls the settings that could change during the application's lifetime. The first and second rows of each channel (address numbers 0, 1, 5, and 6) are the static control latches. The third row of latches for each channel (address numbers 2 and 7) are the dynamic control latches. Address numbers 3 and 4 are internal test registers.

#### **Static Latch Values**

There are some latches in the table that have a static value (i.e. 1, 0, or X). The latches that have a '1' or '0' must be configured with their corresponding value each time that their associated latch bank is configured. The latches that have an 'X' are don't cares and can be configured with any value.

#### Note

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 <sup>3-</sup>Level Select inputs are used for static configuration. These are ternary inputs that make use of logic levels of LOW, MID, and HIGH. The LOW level is usually implemented by direct connection to V<sub>SS</sub> (ground). The HIGH level is usually implemented by direct connection to V<sub>CC</sub> (power). The MID level is usually implemented by not connecting the input (left floating), which allows it to self bias to the proper level.



Table 2. Device Configuration and Control Latch Descriptions

Name	Signal Description
TXCKSELA TXCKSELB	Transmit Clock Select. The initialization value of the TXCKSELx latch = 1. TXCKSELx selects the clock source used to write data into the Transmit Input Register. When TXCKSELx = 1, the associated input register TXDx[9:0] is clocked by REFCLKx↑. In this mode, the phase alignment buffer is bypassed. When TXCKSELx = 0, the associated TXCLKx↑ is used to clock in the input register TXDx[9:0].
TXRATEA TXRATEB	Transmit PLL Clock Rate Select. The initialization value of the TXRATEx latch = 0. TXRATEx is used to select the clock multiplier for the Transmit PLL. When TXRATEx = 0, each transmit PLL multiples the associated REFCLKx± input by 10 to generate the serial bit-rate clock. When TXRATEx = 0, the TXCLKOx output clocks are full-rate clocks and follow the frequency and duty cycle of the associated REFCLKx± input. When TXRATEx = 1, each Transmit PLL multiplies the associated REFCLKx± input by 20 to generate the serial bit-rate clock. When TXRATEx = 1, the TXCLKOx output clocks are twice the frequency rate of the REFCLKx± input. When TXCLKSELx = 1 and TXRATEx = 1, the Transmit Data Inputs are captured using both the rising and falling edges of REFCLKx. TXRATEx = 1 and SPDSELx = LOW, is an invalid state and this combination is reserved.
TXBISTA TXBISTB	<b>Transmit Bist Disabled</b> . The initialization value of the TXBISTx latch = 1. TXBISTx selects if the transmit BIST is disabled or enabled. When TXBISTx = 1, the transmit BIST function is disabled. When TXBISTx = 0, the transmit BIST function is enabled.
OE2A OE2B	<b>Secondary Differential Serial Data Output Driver Enable</b> . The initialization value of the OE2x latch = 0. OE2x selects if the OUT2x± secondary differential output drivers are enabled or disabled. When OE2x = 1, the associated serial data output driver is enabled allowing data to be transmitted from the transmit shifter. When OE2x = 0, the associated serial data output driver is disabled. When a driver is disabled via the configuration interface, it is internally powered down to reduce device power. If both serial drivers for a channel are in this disabled state, the associated internal logic for that channel is also powered down. A device reset (RESET sampled LOW) disables all output drivers.
OE1A OE1B	<b>Primary Differential Serial Data Output Driver Enable</b> . The initialization value of the OE1x latch = 0. OE1x selects if the OUT1x± primary differential output drivers are enabled or disabled. When OE1x = 1, the associated serial data output driver is enabled allowing data to be transmitted from the transmit shifter. When OE1x = 0, the associated serial data output driver is disabled. When a driver is disabled via the configuration interface, it is internally powered down to reduce device power. If both serial drivers for a channel are in this disabled state, the associated internal logic for that channel is also powered down. A device reset (RESET sampled LOW) disables all output drivers.
PABRSTA PABRSTB	Transmit Clock Phase Alignment Buffer Reset. The initialization value of the PABRSTx latch = 1. The PABRSTx is used to re-center the Transmit Phase Align Buffer. When the configuration latch PABRSTx is written as a 0, the phase of the TXCLKx input clock relative to its associated REFCLKx± is initialized. PABRST is an asynchronous input, but is sampled by each TXCLKx↑ to synchronize it to the internal clock domain. PABRSTx is a self clearing latch. This eliminates the requirement of writing a 1 to complete the initialization of the Phase Alignment Buffer.

### **Device Configuration Strategy**

The following is a series of ordered events needed to load the configuration latches on a per channel basis:

- Pulse RESET Low after device power-up. This operation resets both channels. Initialize the JTAG state machine to its reset state as detailed in the JTAG Support section.
- 2. Set the static latch banks for the target channel.
- 3. Set the dynamic bank of latches for the target channel. Enable the output drivers. [Required step.]
- 4. Reset the Phase Alignment Buffer for the target channel. [Optional if phase align buffer is bypassed.]

### JTAG Support

The CYV15G0203TB contains a JTAG port to allow system level diagnosis of device interconnect. Of the available JTAG modes, boundary scan, and bypass are supported. This capability is present only on the LVTTL inputs and outputs and the REFCLKx± clock input. The high-speed serial inputs and outputs are not part of the JTAG test chain. To ensure valid device

operation after power-up (including non-JTAG operation), the JTAG state machine should also be initialized to a reset state. This should be done in addition to the device reset (using RESET). The JTAG state machine can be initialized using TRST (asserting it LOW and de-asserting it or leaving it asserted), or by asserting TMS HIGH for at least 5 consecutive TCLK cycles. This is necessary in order to ensure that the JTAG controller does not enter any of the test modes after device power-up. In this JTAG reset state, the rest of the device will be in normal operation.

**Note**. The order of device reset (using RESET) and JTAG initialization does not matter.

## 3-Level Select Inputs

Each 3-Level select inputs reports as two bits in the scan register. These bits report the LOW, MID, and HIGH state of the associated input as 00, 10, and 11 respectively

## **JTAG ID**

The JTAG device ID for the CYV15G0203TB is '0C810069'x.



**Table 3. Device Control Latch Configuration Table** 

ADDR	Channel	Туре	DATA3	DATA2	DATA1	DATA0	Reset Value
0 (000b)	Α	S	Х	Х	0	Х	1111
1 (001b)	Α	S	Х	0	TXCKSELA	TXRATEA	0110
2 (010b)	Α	D	TXBISTA	OE2A	OE1A	PABRSTA	1001
9 (101b)	В	S	Х	Х	0	Х	1111
10 (110b)	В	S	Х	0	TXCKSELB	TXRATEB	0110
11 (111b)	В	D	TXBISTB	OE2B	OE1B	PABRSTB	1001



## **Maximum Ratings**

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Storage Temperature ......-65 °C to +150 °C Ambient Temperature with Supply Voltage to Ground Potential .....-0.5 V to +3.8 V DC Voltage Applied to LVTTL Outputs Output Current into LVTTL Outputs (LOW) ......60 mA 

Static Discharge Voltage	
(per MIL-STD-883, Method 3015)	> 2000 V
Latch-up Current	> 200 mA

#### **Power-up Requirements**

The CYV15G0203TB requires one power-supply. The Voltage on any input or I/O pin cannot exceed the power pin during power-up.

## **Operating Range**

Range	Ambient Temperature	V <sub>CC</sub>
Commercial	0 °C to +70 °C	+3.3 V ± 5%

### CYV15G0203TB DC Electrical Characteristics

Parameter	Description	Test Conditions	Min	Тур	Max	Unit
LVTTL-comp	patible Outputs					
V <sub>OHT</sub>	Output HIGH Voltage	I <sub>OH</sub> = –4 mA, V <sub>CC</sub> = Min	2.4	-	-	V
V <sub>OLT</sub>	Output LOW Voltage	I <sub>OL</sub> = 4 mA, V <sub>CC</sub> = Min	_	-	0.4	V
I <sub>OST</sub>	Output Short Circuit Current	V <sub>OUT</sub> = 0 V <sup>[9]</sup> , V <sub>CC</sub> = 3.3 V	-20	_	-100	mA
I <sub>OZL</sub>	High Z Output Leakage Current	V <sub>OUT</sub> = 0 V, V <sub>CC</sub>	-20	_	20	μΑ
LVTTL-comp	atible Inputs					
V <sub>IHT</sub>	Input HIGH Voltage		2.0	_	V <sub>CC</sub> + 0.3	V
V <sub>ILT</sub>	Input LOW Voltage		-0.5	_	0.8	V
I <sub>IHT</sub>	Input HIGH Current	REFCLKx Input, V <sub>IN</sub> = V <sub>CC</sub>	_	-	1.5	mA
		Other Inputs, V <sub>IN</sub> = V <sub>CC</sub>	_	_	+40	μΑ
I <sub>ILT</sub>	Input LOW Current	REFCLKx Input, V <sub>IN</sub> = 0.0 V	_	_	-1.5	mA
		Other Inputs, V <sub>IN</sub> = 0.0 V	_	-	-40	μΑ
I <sub>IHPDT</sub>	Input HIGH Current with internal pull-down	$V_{IN} = V_{CC}$	-	-	+200	μΑ
I <sub>ILPUT</sub>	Input LOW Current with internal pull-up	V <sub>IN</sub> = 0.0 V	-	_	-200	μΑ
LVDIFF Inpu	ts: REFCLKx±		- '			
V <sub>DIFF</sub> <sup>[10]</sup>	Input Differential Voltage		400	_	V <sub>CC</sub>	mV
$V_{IHHP}$	Highest Input HIGH Voltage		1.2	_	V <sub>CC</sub>	V
V <sub>ILLP</sub>	Lowest Input LOW voltage		0.0	_	V <sub>CC</sub> /2	V
V <sub>COMREF</sub> <sup>[11]</sup>	Common Mode Range		1.0	-	V <sub>CC</sub> – 1.2	V
3-Level Inpu	ts					
V <sub>IHH</sub>	Three-Level Input HIGH Voltage	Min. ≤ V <sub>CC</sub> ≤ Max.	0.87 × V <sub>CC</sub>	_	V <sub>CC</sub>	V
V <sub>IMM</sub>	Three-Level Input MID Voltage	Min. ≤ V <sub>CC</sub> ≤ Max.	0.47 × V <sub>CC</sub>	_	0.53 × V <sub>CC</sub>	V
$V_{ILL}$	Three-Level Input LOW Voltage	$Min. \leq V_{CC} \leq Max.$	0.0	_	0.13 × V <sub>CC</sub>	V
I <sub>IHH</sub>	Input HIGH Current	V <sub>IN</sub> = V <sub>CC</sub>	-	-	200	μA
I <sub>IMM</sub>	Input MID current	$V_{IN} = V_{CC}/2$	-50	-	50	μA
I <sub>ILL</sub>	Input LOW current	V <sub>IN</sub> = GND	_	_	-200	μΑ

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Tested one output at a time, output shorted for less than one second, less than 10% duty cycle.

<sup>10.</sup> This is the minimum difference in voltage between the true and complement inputs required to ensure detection of a logic-1 or logic-0. A logic-1 exists when the true (+) input is more positive than the complement (-) input. A logic-0 exists when the complement (-) input is more positive than true (+) input.

11. The common mode range defines the allowable range of REFCLKx+ and REFCLKx- when REFCLKx+ = REFCLKx-. This marks the zero-crossing between the true and complement inputs as the signal switches between a logic-1 and a logic-0.



## CYV15G0203TB DC Electrical Characteristics (continued)

Parameter	Description	Test Conditions		Min	Тур	Max	Unit
Differential (	Differential CML Serial Outputs: OUTA1±, OUTA2±, OUTB1±, OUTB2±, OUTC1±, OUTC2±, OUTD1±, OUTD2±						
V <sub>OHC</sub>	Output HIGH Voltage	100 $\Omega$ differential load		$V_{CC} - 0.5$	_	V <sub>CC</sub> - 0.2	V
	(V <sub>cc</sub> Referenced)	150 $\Omega$ differential load		V <sub>CC</sub> – 0.5	_	V <sub>CC</sub> – 0.2	V
V <sub>OLC</sub>	Output LOW Voltage	ge 100 Ω differential load		V <sub>CC</sub> – 1.4	_	$V_{CC} - 0.7$	V
	(V <sub>CC</sub> Referenced)	150 $\Omega$ differential load		V <sub>CC</sub> – 1.4	_	V <sub>CC</sub> - 0.7	V
V <sub>ODIF</sub>	Output Differential Voltage	100 $\Omega$ differential load		450	_	900	mV
	(OUT+) – (OUT–)	150 $Ω$ differential load		560	_	1000	mV
Power Supp	Power Supply						
I <sub>CC</sub> [12, 13]	Max Power Supply Current	REFCLKx = MAX	Commercial	_	435	530	mA
I <sub>CC</sub> [12, 13]	Typical Power Supply Current	REFCLKx = 125 MHz	Commercial	_	425	520	mA

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Notes

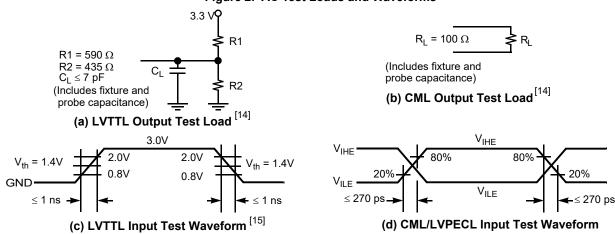
12. Maximum I<sub>CC</sub> is measured with V<sub>CC</sub> = MAX, T<sub>A</sub> = 25 °C, with both channels and Serial Line Drivers enabled, sending a continuous alternating 01 pattern, and outputs unloaded.

13. Typical I<sub>CC</sub> is measured under similar conditions except with V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25 °C, with both channels enabled and one Serial Line Driver per channel sending a continuous alternating 01 pattern. The redundant outputs on each channel are powered down.



## **AC Test Loads and Waveforms**

Figure 2. AC Test Loads and Waveforms



#### Notes

<sup>14.</sup> Cypress uses constant current (ATE) load configurations and forcing functions. This figure is for reference only.

<sup>15.</sup> The LVTTL switching threshold is 1.4 V. All timing references are made relative to where the signal edges cross the threshold voltage.



## CYV15G0203TB AC Electrical Characteristics

Parameter	Description	Condition	Min	Тур	Max	Unit
CYV15G0203TB	Transmitter LVTTL Switching Characteristics					
Over the Operating	Range					
f <sub>TS</sub>	TXCLKx Clock Cycle Frequency		19.5	_	150	MHz
t <sub>TXCLK</sub>	TXCLKx Period = 1/f <sub>TS</sub>		6.66	-	51.28	ns
t <sub>TXCLKH</sub> <sup>[16]</sup>	TXCLKx HIGH Time		2.2	-	_	ns
t <sub>TXC  KI</sub> <sup>[16]</sup>	TXCLKx LOW Time		2.2	-	_	ns
t <sub>TXCLKR</sub> [16, 17, 18, 19]	TXCLKx Rise Time		0.2	-	1.7	ns
t <sub>TXCLKF</sub> [16, 17, 18, 19]	TXCLKx Fall Time		0.2	-	1.7	ns
t <sub>TXDS</sub>	Transmit Data Set-up Time to TXCLKx↑ (TXCKSELx :	= 0)	2.2	_	_	ns
t <sub>TXDH</sub>	Transmit Data Hold Time from TXCLKx↑ (TXCKSELx	= 0)	1.0	-	_	ns
f <sub>TOS</sub>	TXCLKOx Clock Frequency = 1x or 2x REFCLKx Frequency		19.5	-	150	MHz
t <sub>TXCLKO</sub>	TXCLKOx Period = 1/f <sub>TOS</sub>				51.28	ns
t <sub>TXCLKOD</sub>	TXCLKO Duty Cycle centered at 60% HIGH time		-1.9	-	0	ns
	REFCLKx Switching Characteristics				1	
Over the Operating	Range					
f <sub>REF</sub>	REFCLKx Clock Frequency		19.5	_	150	MHz
t <sub>REFCLK</sub>	REFCLKx Period = 1/f <sub>RFF</sub>		6.6	-	51.28	ns
t <sub>REFH</sub>	REFCLKx HIGH Time - Half Rate (TXRATEx = 1)		5.9	-	_	ns
	REFCLKx HIGH Time - Full Rate (TXRATEx = 0)		2.9 <sup>[16]</sup>	-	_	ns
t <sub>REFL</sub>	REFCLKx LOW Time - Half Rate (TXRATEx = 1)		5.9	-	_	ns
	REFCLKx LOW Time - Full Rate (TXRATEx = 0)		2.9 <sup>[16]</sup>	-	_	ns
t <sub>REFD</sub> <sup>[20]</sup>	REFCLKx Duty Cycle		30	_	70	%
t <sub>RFFR</sub> [16, 17, 18, 19]	REFCLKx Rise Time (20%–80%)		_	_	2	ns
t <sub>REFF</sub> <sup>[16, 17, 18, 19]</sup>	REFCLKx Fall Time (20%–80%)		_	-	2	ns
t <sub>TREFDS</sub>	Transmit Data Set-up Time to REFCLKx - Full Rate (TXRATEx = 0, TXCKSELx = 1)		2.4	-	_	ns
	Transmit Data Set-up Time to REFCLKx - Half Rate (TXRATEx = 1, TXCKSELx = 1)		2.3	-	_	ns
t <sub>TREFDH</sub>	Transmit Data Hold Time from REFCLKx - Full Rate (TXRATEx = 0, TXCKSELx = 1)		1.0	-	_	ns
	Transmit Data Hold Time from REFCLKx - Half Rate (TXRATEx = 1, TXCKSELx = 1)	1.6	-	_	ns	
CYV15G0203TB	<b>Bus Configuration Write Timing Characteristi</b>	cs	ı		ı	
Over the Operating						
t <sub>DATAH</sub>	Bus Configuration Data Hold		0	_	_	ns
t <sub>DATAS</sub>	Bus Configuration Data Setup		10	_	_	ns
t <sub>WRENP</sub>	Bus Configuration WREN Pulse Width		10	_	_	ns
****	ı				1	L

<sup>Notes
16. Tested initially and after any design or process changes that may affect these parameters, but not 100% tested.
17. The ratio of rise time to falling time must not vary by greater than 2:1.
18. For a given operating frequency, neither rise or fall specification can be greater than 20% of the clock-cycle period or the data sheet maximum time.
19. All transmit AC timing parameters measured with 1 ns typical rise time and fall time.
20. The duty cycle specification is a simultaneous condition with the t<sub>REFH</sub> and t<sub>REFL</sub> parameters. This means that at faster character rates the REFCLKx± duty cycle cannot be as large as 30%–70%.</sup> 



## CYV15G0203TB AC Electrical Characteristics (continued)

Parameter	Description	Condition	Min	Тур	Max	Unit
CYV15G0203TB	JTAG Test Clock Characteristics					
Over the Operating	Range					
f <sub>TCLK</sub>	JTAG Test Clock Frequency		_	_	20	MHz
t <sub>TCLK</sub>	JTAG Test Clock Period		50	_	_	ns
CYV15G0203TB	Device RESET Characteristics			·	•	<u>.</u>
Over the Operating	Range					
t <sub>RST</sub>	Device RESET Pulse Width		30	_	_	ns
CYV15G0203TB	Transmit Serial Output Characteristics			•	•	
Over the Operating	Range					
t <sub>B</sub>	Bit Time		5128	_	660	ps
t <sub>RISE</sub> <sup>[21]</sup>	CML Output Rise Time 20-80% (CML Test Load)	SPDSELx = HIGH	50	_	270	ps
		SPDSELx = MID	100	_	500	ps
		SPDSELx =LOW	180	_	1000	ps
t <sub>FALL</sub> <sup>[21]</sup>	CML Output Fall Time 80–20% (CML Test Load)	SPDSELx = HIGH	50	_	270	ps
		SPDSELx = MID	100	_	500	ps
		SPDSELx =LOW	180	_	1000	ps
CYV15G0203TB	Transmitter PLL Characteristics					
Over the Operating	Range					
t <sub>JTGENSD</sub> <sup>[21, 22]</sup>	Transmit Jitter Generation - SD Data Rate	REFCLKx = 27 MHz	_	200	_	ps
t <sub>JTGENHD</sub> <sup>[21, 22]</sup>	Transmit Jitter Generation - HD Data Rate	REFCLKx = 148.5 MHz	-	76	_	ps
t <sub>TXLOCK</sub>	Transmit PLL lock to REFCLKx±		_	_	200	μS

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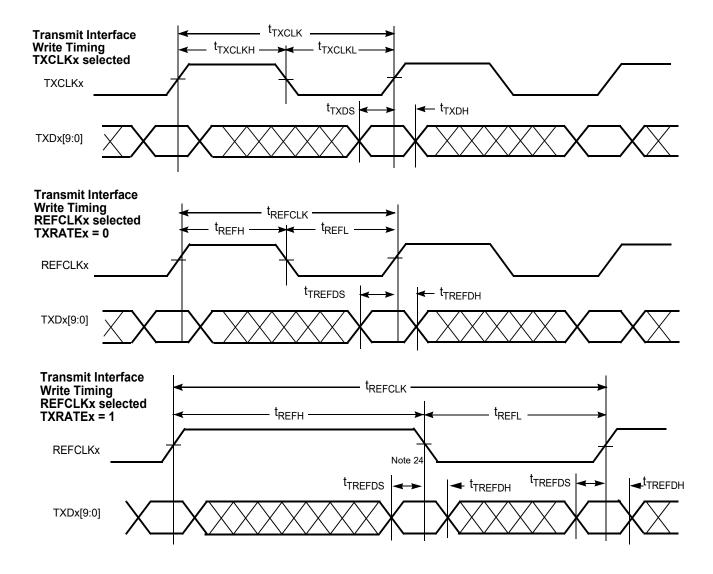
Notes
21. Tested initially and after any design or process changes that may affect these parameters, but not 100% tested.
22. While sending BIST data at the corresponding data rate, after 10,000 histogram hits on a digital sampling oscilloscope, time referenced to REFCLKx± input.



## Capacitance

Parameter [23]	Description	Test Conditions	Max	Unit
C <sub>INTTL</sub>	TTL Input Capacitance	$T_A = 25  ^{\circ}\text{C},  f_0 = 1  \text{MHz},  V_{CC} = 3.3  \text{V}$	7	pF
C <sub>INPECL</sub>	PECL input Capacitance	$T_A = 25 ^{\circ}\text{C},  f_0 = 1  \text{MHz},  V_{CC} = 3.3  \text{V}$	4	pF

## CYV15G0203TB HOTLink II Transmitter Switching Waveforms

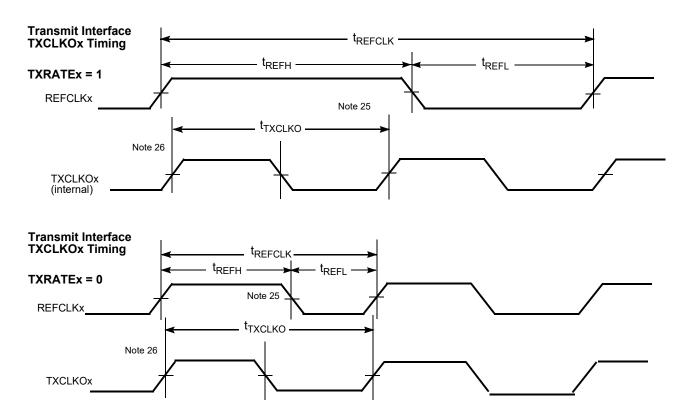


#### Note

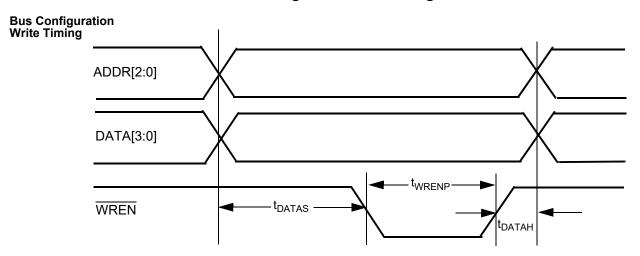
- 23. Tested initially and after any design or process changes that may affect these parameters, but not 100% tested.
- 24. When REFCLKx± is configured for half-rate operation (TXRATEx = 1) and data is captured using REFCLKx instead of a TXCLKx clock. Data is captured using both the rising and falling edges of REFCLKx.



## CYV15G0203TB HOTLink II Transmitter Switching Waveforms (continued)



## CYV15G0203TB HOTLink II Bus Configuration Switching Waveforms



Notes
25. The TXCLKOx output remains at the character rate regardless of the state of TXRATEx and does not follow the duty cycle of REFCLKx±.
26. The rising edge of TXCLKOx output has no direct phase relationship to the REFCLKx± input.



## **Package Coordinate Signal Allocation**

	_			
~			Signal Name	
			NC	
		C08	GND	
NC	NO CONNECT	C09	NC	
NC	NO CONNECT	C10	NC	
VCC	POWER	C11	DATA[2]	
NC	NO CONNECT		DATA[0]	
OUTB1-	CML OUT	C13	GND	
GND	GROUND	C14	NC	
GND	GROUND	C15	SPDSELB	
OUTB2-	CML OUT	C16	VCC	
GND	GROUND	C17	NC	
OUTA1-	CML OUT	C18	TRST	
GND	GROUND	C19	GND	
GND	GROUND	C20	TDO	
OUTA2-	CML OUT	D01	TCLK	
VCC	POWER	D02	RESET	
VCC	POWER	D03	VCC	
NC	NO CONNECT	D04	VCC	
VCC	POWER	D05	VCC	
NC	NO CONNECT	D06	VCC	
VCC	POWER	D07	NC	
NC	NO CONNECT	D08	GND	
VCC	POWER	D09	GND	
NC	NO CONNECT	D10	DATA[3]	
VCC	POWER	D11	DATA[1]	
VCC	POWER	D12	GND	
OUTB1+	CML OUT	D13	GND	
GND	GROUND	D14	GND	
NC	NO CONNECT	D15	NC	
OUTB2+	CML OUT	D16	VCC	
NC	NO CONNECT	D17	NC	
OUTA1+	CML OUT	D18	NC	
GND	GROUND	D19	SCANEN2	
NC	NO CONNECT	D20	TMEN3	
OUTA2+	CML OUT	E01	VCC	
VCC	POWER	E02	VCC	
NC	NO CONNECT	E03	VCC	
NC	NO CONNECT	E04	VCC	
NC	NO CONNECT	E17	VCC	
NC	NO CONNECT	E18	VCC	
TDI	LVTTL IN PU	E19	VCC	
TMS	LVTTL IN PU	E20	VCC	
	Signal Name	Signal Name   Signal Type   NC   NO CONNECT   VCC   POWER   NC   NO CONNECT   OUTB1-   CML OUT   GND   GROUND   GND   GROUND   OUTB2-   CML OUT   GND   GROUND   OUTA1-   CML OUT   GND   GROUND   OUTA2-   CML OUT   VCC   POWER   VCC   POWER   NC   NO CONNECT   VCC   POWER   OUTB1+   CML OUT   GND   GROUND   NC   NO CONNECT   OUTB2+   CML OUT   GND   GROUND   NC   NO CONNECT   OUTA1+   CML OUT   GND   GROUND   NC   NO CONNECT   OUTA2+   CML OUT   VCC   POWER   NC   NO CONNECT   OUTA2+   CML OUT   VCC   POWER   NC   NO CONNECT   OUTA2+   CML OUT   VCC   POWER   NC   NO CONNECT   N	NC         NO CONNECT         C07           NC         NO CONNECT         C08           NC         NO CONNECT         C09           NC         NO CONNECT         C10           VCC         POWER         C11           NC         NO CONNECT         C12           OUTB1-         CML OUT         C13           GND         GROUND         C14           GND         GROUND         C15           OUTB2-         CML OUT         C16           GND         GROUND         C19           GND         GROUND         C20           OUTA1-         CML OUT         C18           GND         GROUND         C20           OUTA2-         CML OUT         D01           VCC         POWER         D02           VCC         POWER         D03           NC         NO CONNECT         D04           VCC         POWER         D05           NC         NO CONNECT         D08           NC         NO CONNECT         D10           NC         NO CONNECT         D15           OUTB1+         CML OUT         D16           NC         NO CO	

ocation					
Ball ID	Signal Name	Signal Type			
C07	NC	NO CONNECT			
C08	GND	GROUND			
C09	NC	NO CONNECT			
C10	NC	NO CONNECT			
C11	DATA[2]	LVTTL IN PU			
C12	DATA[0]	LVTTL IN PU			
C13	GND	GROUND			
C14	NC	NO CONNECT			
C15	SPDSELB	3-LEVEL SEL			
C16	VCC	POWER			
C17	NC	NO CONNECT			
C18	TRST	LVTTL IN PU			
C19	GND	GROUND			
C20	TDO	LVTTL 3-S OUT			
D01	TCLK	LVTTL IN PD			
D02	RESET	LVTTL IN PU			
D03	VCC	POWER			
D04	VCC	POWER			
D05	VCC	POWER			
D06	VCC	POWER			
D07	NC	NO CONNECT			
D08	GND	GROUND			
D09	GND	GROUND			
D10	DATA[3]	LVTTL IN PU			
D11	DATA[1]	LVTTL IN PU			
D12	GND	GROUND			
D13	GND	GROUND			
D14	GND	GROUND			
D15	NC	NO CONNECT			
D16	VCC	POWER			
D17	NC	NO CONNECT			
D18	NC	NO CONNECT			
D19	SCANEN2	LVTTL IN PD			
D20	TMEN3	LVTTL IN PD			
E01	VCC	POWER			
E02	VCC	POWER			
E03	VCC	POWER			
E04	VCC	POWER			
E17	VCC	POWER			
E18	VCC	POWER			
E19	VCC	POWER			
E20	VCC	POWER			
F01	NC	NO CONNECT			

Ball ID	Signal Name	Signal Type
F17	NC	NO CONNECT
F18	NC	NO CONNECT
F19	NC	NO CONNECT
F20	NC	NO CONNECT
G01	GND	GROUND
G02	WREN	LVTTL IN PU
G03	GND	GROUND
G04	GND	GROUND
G17	NC	NO CONNECT
G18	NC	NO CONNECT
G19	SPDSELA	3-LEVEL SEL
G20	NC	NO CONNECT
H01	GND	GROUND
H02	GND	GROUND
H03	GND	GROUND
H04	GND	GROUND
H17	GND	GROUND
H18	GND	GROUND
H19	GND	GROUND
H20	GND	GROUND
J01	GND	GROUND
J02	GND	GROUND
J03	GND	GROUND
J04	GND	GROUND
J17	NC	NO CONNECT
J18	NC	NO CONNECT
J19	NC	NO CONNECT
J20	NC	NO CONNECT
K01	NC	NO CONNECT
K02	NC	NO CONNECT
K03	GND	GROUND
K04	GND	GROUND
K17	NC	NO CONNECT
K18	NC	NO CONNECT
K19	NC	NO CONNECT
K20	NC	NO CONNECT
L01	NC	NO CONNECT
L02	NC	NO CONNECT
L03	NC	NO CONNECT
L04	GND	GROUND
L17	NC	NO CONNECT
L18	NC	NO CONNECT
L19	NC	NO CONNECT



## Package Coordinate Signal Allocation (continued)

Ball ID	Signal Name	Signal Type
C04	VCC	POWER
C05	VCC	POWER
C06	NC	NO CONNECT
M03	NC	NO CONNECT
M04	NC	NO CONNECT
M17	NC	NO CONNECT
M18	NC	NO CONNECT
M19	NC	NO CONNECT
M20	GND	GROUND
N01	GND	GROUND
N02	GND	GROUND
N03	GND	GROUND
N04	GND	GROUND
N17	GND	GROUND
N18	GND	GROUND
N19	GND	GROUND
N20	GND	GROUND
P01	NC	NO CONNECT
P02	NC	NO CONNECT
P03	NC	NO CONNECT
P04	NC	NO CONNECT
P17	GND	GROUND
P18	GND	GROUND
P19	GND	GROUND
P20	GND	GROUND
R01	NC	NO CONNECT
R02	NC	NO CONNECT
R03	NC	NO CONNECT
R04	NC	NO CONNECT
R17	VCC	POWER
R18	VCC	POWER
R19	VCC	POWER
R20	VCC	POWER
T01	VCC	POWER
T02	VCC	POWER
T03	VCC	POWER
T04	VCC	POWER
T17	VCC	POWER
T18	VCC	POWER
T19	VCC	POWER
T20	VCC	POWER
U01	TXDB[0]	LVTTL IN
U02	TXDB[1]	LVTTL IN

cation	1 (continued)	
Ball ID	Signal Name	Signal Type
F02	NC	NO CONNECT
F03	VCC	POWER
F04	NC	NO CONNECT
U03	TXDB[2]	LVTTL IN
U04	TXDB[9]	LVTTL IN
U05	VCC	POWER
U06	NC	NO CONNECT
U07	NC	NO CONNECT
U08	GND	GROUND
U09	TXDA[9]	LVTTL IN
U10	ADDR [0]	LVTTL IN PU
U11	REFCLKB-	PECL IN
U12	TXDA[1]	LVTTL IN
U13	GND	GROUND
U14	TXDA[4]	LVTTL IN
U15	TXDA[8]	LVTTL IN
U16	VCC	POWER
U17	NC	NO CONNECT
U18	VCC	POWER
U19	NC	NO CONNECT
U20	NC	NO CONNECT
V01	TXDB[3]	LVTTL IN
V02	TXDB[4]	LVTTL IN
V03	TXDB[8]	LVTTL IN
V04	NC	NO CONNECT
V05	VCC	POWER
V06	NC	NO CONNECT
V07	NC	NO CONNECT
V08	GND	GROUND
V09	NC	NO CONNECT
V10	GND	GROUND
V11	REFCLKB+	PECL IN
V12	TXCLKOA	LVTTL OUT
V13	GND	GROUND
V14	TXDA[3]	LVTTL IN
V15	TXDA[7]	LVTTL IN
V16	VCC	POWER
V17	NC	NO CONNECT
V18	NC	NO CONNECT
V19	NC	NO CONNECT
V20	NC	NO CONNECT
W01	TXDB[5]	LVTTL IN
W02	TXDB[7]	LVTTL IN

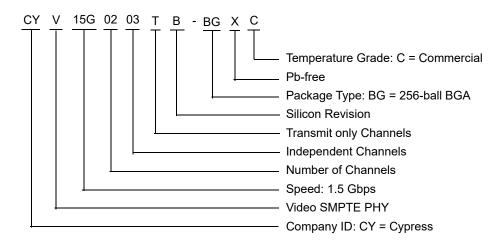
Ball ID	Signal Name	Signal Type
L20	GND	GROUND
M01	NC	NO CONNECT
M02	NC	NO CONNECT
W03	NC	NO CONNECT
W04	NC	NO CONNECT
W05	VCC	POWER
W06	NC	NO CONNECT
W07	NC	NO CONNECT
W08	GND	GROUND
W09	ADDR [2]	LVTTL IN PU
W10	ADDR [1]	LVTTL IN PU
W11	NC	NO CONNECT
W12	TXERRA	LVTTL OUT
W13	GND	GROUND
W14	TXDA[2]	LVTTL IN
W15	TXDA[6]	LVTTL IN
W16	VCC	POWER
W17	NC	NO CONNECT
W18	REFCLKA+	PECL IN
W19	NC	NO CONNECT
W20	NC	NO CONNECT
Y01	TXDB[6]	LVTTL IN
Y02	TXCLKB	LVTTL IN PD
Y03	NC	NO CONNECT
Y04	NC	NO CONNECT
Y05	VCC	POWER
Y06	NC	NO CONNECT
Y07	NC	NO CONNECT
Y08	GND	GROUND
Y09	TXCLKOB	LVTTL OUT
Y10	NC	NO CONNECT
Y11	TXCLKA	LVTTL IN PD
Y12	NC	NO CONNECT
Y13	GND	GROUND
Y14	TXDA[0]	LVTTL IN
Y15	TXDA[5]	LVTTL IN
Y16	VCC	POWER
Y17	TXERRB	LVTTL OUT
Y18	REFCLKA-	PECL IN
Y19	NC	NO CONNECT
Y20	NC	NO CONNECT



## **Ordering Information**

Speed	Ordering Code	Package Name	Package Type	Operating Range
Standard	CYV15G0203TB-BGXC	BJ256	256-ball Thermally Enhanced Ball Grid Array (Pb-free)	Commercial

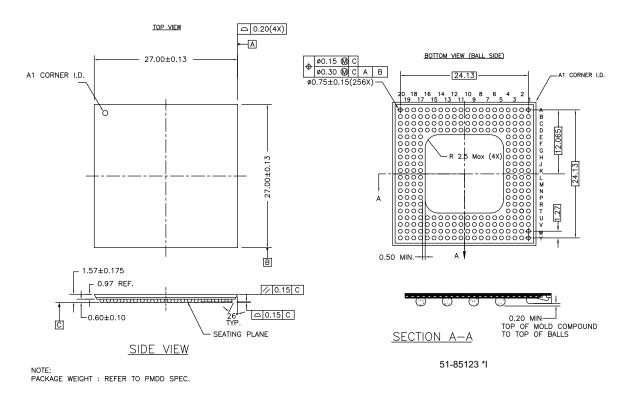
## **Ordering Code Definitions**





## **Package Diagram**

Figure 3. 256-ball L2BGA (27 × 27 × 1.57 mm) BL256/BJ256, 51-85123





## **Acronyms**

Acronym	Description		
BGA	ball grid array		
BIST	built in self test		
CML	current mode logic		
I/O	input/output		
JTAG	joint test action group		
LFSR	linear feedback shift register		
LSB	least significant bit		
LVCMOS	low voltage complementary metal oxide semiconductor		
LVPECL	low voltage positive emitter-coupled logic		
LVTTL	low voltage transistor-transistor logic		
PECL	positive emitter coupled logic		
PLL	phase locked loop		
TCLK	test clock		
TDI	test data in		
TDO	test data out		
TMS	test mode select		
TTL	transistor-transistor logic		

## **Document Conventions**

## **Units of Measure**

Symbol	Unit of Measure			
°C	degree Celsius			
MHz	Mega Hertz			
μA	micro Amperes			
μs	micro seconds			
mA	milli Amperes			
mm	milli meter			
mV	milli Volts			
ns	nano seconds			
Ω	ohms			
%	percent			
pF	pico Farads			
ps	pico seconds			
V	Volts			
W	Watts			



# **Document History Page**

Document Title: CYV15G0203TB, Independent Clock Dual HOTLink II™ Serializer Document Number: 38-02105						
Rev.	ECN No.	Issue Date	Orig. of Change	Description of Change		
**	246850	See ECN	FRE	New data sheet		
*A	338721	See ECN	SUA	Added Pb-Free package option availability		
*B	384307	See ECN	AGT	Revised setup and hold times (t <sub>TXDH</sub> , t <sub>TREFDS</sub> , t <sub>TREFDH</sub> )		
*C	1034145	See ECN	UKK	Added clarification for the necessity of JTAG controller reset and the methods to implement it.		
*D	2897889	03/23/10	CGX	Updated Ordering Information (Removed inactive parts). Updated Package Diagram.		
*E	3336783	08/04/2011	SAAC	Added Ordering Code Definitions. Updated Package Diagram. Added Acronyms and Units of Measure. Updated in new template.		
*F	4497471	09/09/2014	YLIU	Updated Package Diagram: spec 51-85123 – Changed revision from *G to *I.  Updated in new template.  Completing Sunset Review.		
*G	5855418	08/18/2017	YLIU	Updated Cypress logo and Copyright information.		



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